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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/700,329	SILVA ET AL.	
Examiner	Art Unit	
Justin Y. Lee	2617	

	SEAR	CHED	
Class	Subclass	Date	Examiner
455	63.4,562.1	7/3/2007	JL

INT	ERFERENC	CE SEARCH	ED
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	RCH NOTES SEARCH STRATEG	Y)
	DATE	EXMR
East	7/3/2007	JL
Duc Nguyen	7/3/2007	JL